Electronic structure and hot carrier relaxation in wet <001> anatase TiO₂ nanowire

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A non-adiabatic excited state dynamics of <001> anatase TiO₂ nanowire (NW)¹ is investigated by combining density matrix formalism and *ab initio* electronic structure calculations.² A periodic boundary condition in the <001> direction is applied to a stochiometric atomic model of anatase titania $Ti_{25}O_{50}$ while (100) and (010) faces are exposed to vacuum or to one monolayer of H₂O molecules. The electronic structures of the models are described by GGA-PBE³ and HSE06⁴ functionals with PAW potentials in VASP software and show an agreement to experiment [Figure 1]. Carrier dynamics is computed beyond the Born-Oppenheimer approximation using on-the-fly couplings. A time evolution of Kohn-Sham orbital populations is obtained for different electronic excitations. The analytical and numerical results on the electron relaxation show an agreement. The electron non-radiative relaxation to the bottom of conduction band involves Ti 3d orbitals, while the hole non-radiative relaxation to the top of valence band involves surface O 2p orbitals. TiO₂ NWs in vacuum and in aqueous environment exhibit different dynamics. In wet NWs, computed relaxation of electrons (holes) is approximately 2 (4) times faster when compared with the vacuum environment. The understanding of the relaxation pathways of photo-generated electron and hole is important for optimizing efficiency of materials for photovoltaics and photocatalysis applications.



Figure 1 The calculated absorption spectra of wet TiO_2 NW and the experimental spectra of concentrated TiO_2 nanorod water solution.

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